# **MOSFET** – Power, Single, N-Channel, DPAK/IPAK 30 V, 41 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

#### **Applications**

- CPU Power Delivery
- DC-DC Converters

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	neter		Symbol	Value	Unit
Drain-to-Source Volta	ige		$V_{DSS}$	30	V
Gate-to-Source Volta	Gate-to-Source Voltage			±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	12.1	Α
Current (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 100°C		8.6	
Power Dissipation (R <sub>θJA</sub> ) (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.6	W
Continuous Drain Current (R <sub>0.IA</sub> )		T <sub>A</sub> = 25°C	I <sub>D</sub>	8.8	Α
(Note 2)	Steady State	T <sub>A</sub> = 100°C		6.2	
Power Dissipation (R <sub>θJA</sub> ) (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.37	W
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	41	Α
Current (R <sub>0JC</sub> ) (Note 1)		T <sub>C</sub> = 100°C		29	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	29.4	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	167	Α
Current Limited by Pac	kage	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	60	Α
Operating Junction and	I Storage ∃	Temperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body I	Source Current (Body Diode)				Α
Drain to Source dV/dt			dV/dt	7.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, L = 0.1 mH, $I_{L(pk)}$ = 24 A, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	28	mJ
	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

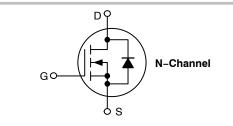
- 1. Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	8.0 mΩ @ 10 V	41 A
30 V	12 m $\Omega$ @ 4.5 V	417







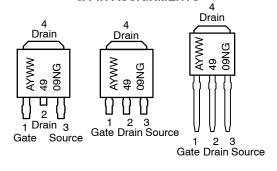


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AD **IPAK** (Straight Lead)

**CASE 369D IPAK** (Straight Lead DPAK)

## **MARKING DIAGRAMS & PIN ASSIGNMENTS**



= Assembly Location

= Year WW = Work Week 4909N = Device Code = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	5.1	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	4.3	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	58.2	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	110	

<sup>3.</sup> Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.

# FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		•	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	<sub>D</sub> = 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				± 100	nA
ON CHARACTERISTICS (Note 5)							•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I	<sub>D</sub> = 250 μA	1.0	1.7	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		6.5	8.0	mΩ
			I <sub>D</sub> = 15 A		6.5		1
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		9.5	12	
			I <sub>D</sub> = 15 A		9.5		
Forward Transconductance	gFS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 30 A			52		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				1314		pF
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V, f}$ $V_{DS} =$			487		1
Reverse Transfer Capacitance	C <sub>rss</sub>	<b>V</b> DS −	15 V		17.4		
Total Gate Charge	Q <sub>G(TOT)</sub>				7.6		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 V,$	V <sub>DS</sub> = 15 V,		2.1		
Gate-to-Source Charge	$Q_{GS}$	$I_D = 3$	30 A		4.3		
Gate-to-Drain Charge	$Q_{GD}$	1			1.3		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A			17.5		nC
SWITCHING CHARACTERISTICS (Note 6)	•					•	•
Turn-On Delay Time	t <sub>d(on)</sub>				11		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V,	V <sub>DS</sub> = 15 V,		21		1
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 15 A, F			17		
Fall Time	t <sub>f</sub>		-		2.7		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

7. Assume terminal length of 110 mils.

<sup>4.</sup> Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
Turn-On Delay Time	t <sub>d(on)</sub>			8.0		ns		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,		19		]		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$		21				
Fall Time	t <sub>f</sub>			2.3		]		
DRAIN-SOURCE DIODE CHARACTERISTICS								
Face and Display Valleys	``	T 0500		0.0		\ /		

Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C	0.9	1.1	V
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C	0.8		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 30 A		30		ns
Charge Time	ta			16		
Discharge Time	tb			14		
Reverse Recovery Time	$Q_{RR}$	]		20		nC

## PACKAGE PARASITIC VALUES

Source Inductance (Note 7)	L <sub>S</sub>		2.99		nΗ
Drain Inductance, DPAK	L <sub>D</sub>		0.0164		
Drain Inductance, IPAK (Note 7)	L <sub>D</sub>	$T_A = 25^{\circ}C$	1.88		
Gate Inductance (Note 7)	L <sub>G</sub>		4.9		
Gate Resistance	R <sub>G</sub>		1.0	2.0	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

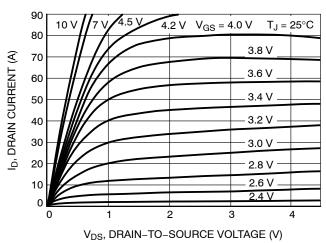
- 6. Switching characteristics are independent of operating junction temperatures.
- 7. Assume terminal length of 110 mils.

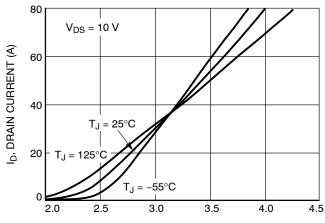
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NTD4909NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4909N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4909N-35G	IPAK Trimmed Lead (Pb-Free)	75 Units / Rail

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### TYPICAL CHARACTERISTICS





V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

Figure 1. On-Region Characteristics

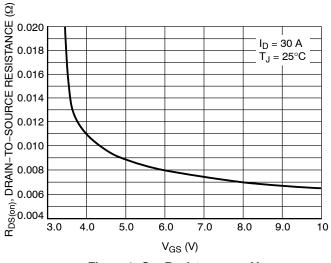


Figure 3. On-Resistance vs. V<sub>GS</sub>

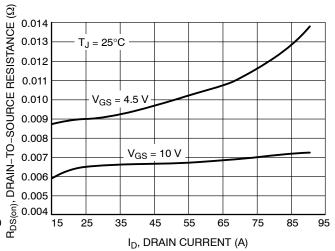


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

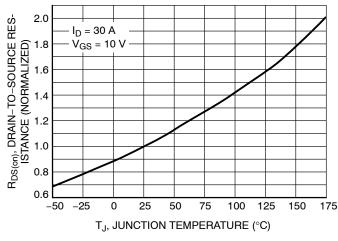


Figure 5. On-Resistance Variation with **Temperature** 

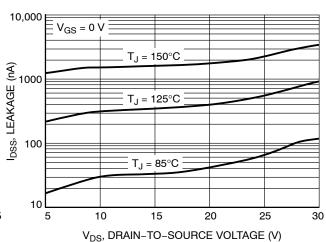


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

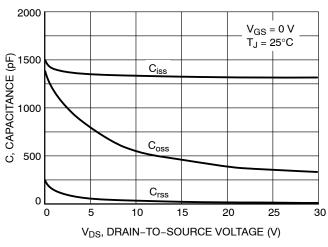


Figure 7. Capacitance Variation

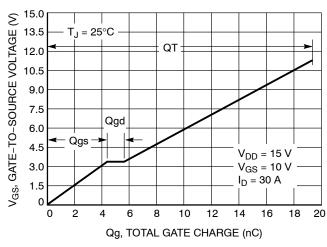


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

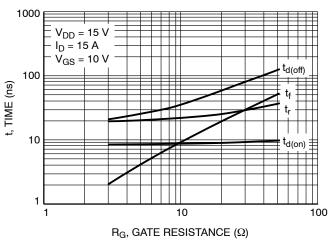


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

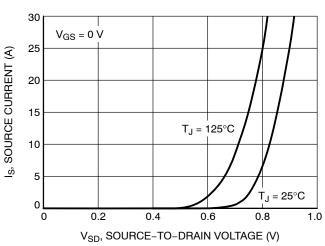


Figure 10. Diode Forward Voltage vs. Current

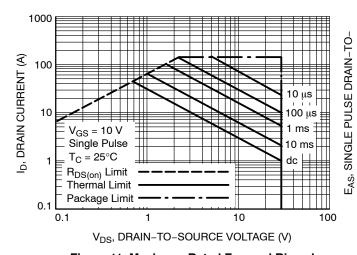


Figure 11. Maximum Rated Forward Biased Safe Operating Area

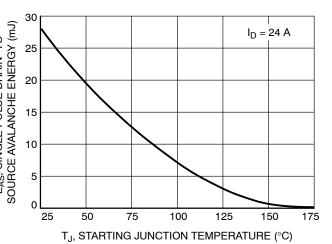


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL CHARACTERISTICS**

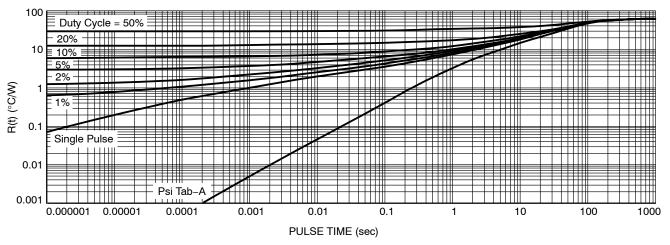


Figure 13. FET Thermal Response

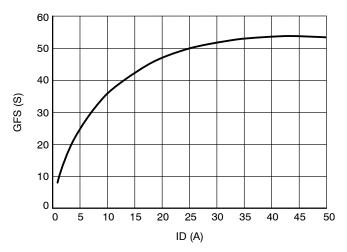
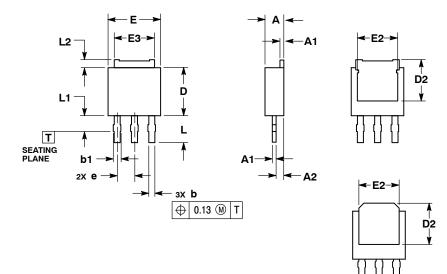


Figure 14. GFS vs. ID

#### **PACKAGE DIMENSIONS**

#### 3.5 MM IPAK, STRAIGHT LEAD

CASE 369AD ISSUE B



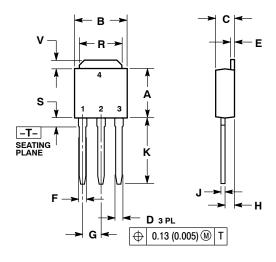
- NOTES:
  1.. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2.. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

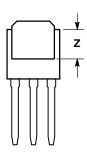
	MILLIN	IETERS
DIM	MIN	MAX
Α	2.19	2.38
A1	0.46	0.60
A2	0.87	1.10
b	0.69	0.89
b1	0.77	1.10
D	5.97	6.22
D2	4.80	
E	6.35	6.73
E2	4.57	5.45
E3	4.45	5.46
е	2.28	BSC
L	3.40	3.60
L1		2.10
L2	0.89	1.27

- STYLE 2:
  PIN 1. GATE
  2. DRAIN
  3. SOURCE
  4. DRAIN

**IPAK** CASE 369D ISSUE C

OPTIONAL CONSTRUCTION





- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

#### STYLE 2:

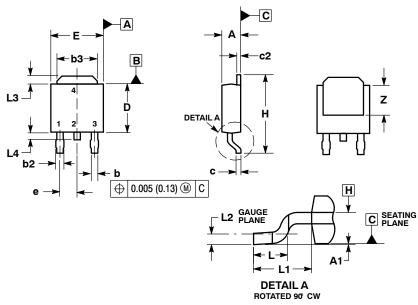
PIN 1. GATE 2. DRAIN

- 3. SOURCE 4. DRAIN

#### **PACKAGE DIMENSIONS**

#### **DPAK (SINGLE GUAGE)**

CASE 369AA ISSUE B



#### NOTES:

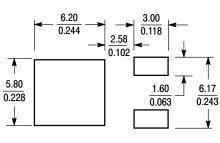
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14 5M 1994
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- MENSIONS DAND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74 REF	
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

DRAIN

#### **SOLDERING FOOTPRINT\***



SCALE 3:1  $\left(\frac{mm}{inches}\right)$ 

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<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.